Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/816,179	LEE ET AL.
Examiner	Art Unit
Rudy Zervigon	1763

SEARCHED				
Class	Subclass	Date	Examiner	
118	697	8/4/2007	RZ	
118	696	8/4/2007	RZ	
118	715	8/4/2007	RZ	
118	719	8/4/2007	RZ	
118	725	8/4/2007	RZ	
156	345.24	8/4/2007	RZ	
156	345.27	8/4/2007	RZ	
156	345.31	8/4/2007	RZ	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
118	697	8/4/2007	RZ		
118	696	8/4/2007	RZ		
118	715	8/4/2007	RŽ		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
·	DATE	EXMR
20050047927 20040055539 20030198578 20030196680 20030188683 20030051662 20070119369 20060201426 20050274322 20050223989	8/3/2007	RZ
20050000435 20050000434 20040255862 6086679 6051321	8/3/2007	RZ
LEE-CHUNG-J.in. or KUMAR-ATUL.in. or CHEN-CHIEH.in. or PIKOVSKY-YURI.in.	8/3/2007	RZ
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